

## 承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	KBAN3216E245H0201
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type H02
版本 VERSION	:	V1.2
日期 ISSUE DATE	:	2020/08/25

客戶承認	
CUSTOMER APPROVED	

工 程 部 R&D CENTER					
承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN			
Ziv	Alex	Jerry			





## 萬誠科技股份有限公司

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## OneWave Electronic Co., Ltd.

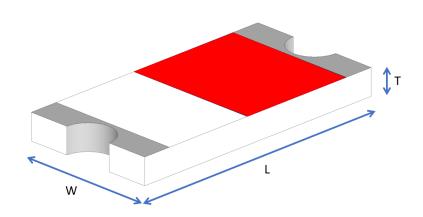
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# 3216 Chip antenna

## For Bluetooth / WLAN Applications



P/N: KBAN3216E245H0201

	Dimension (mm)
L	3.23 ± 0.20
W	1.66 ± 0.20
Т	0.45 ± 0.20



#### **Part Number Information**

KBAN 3216 E 245 H 02 01
A B C D E F G

A	Product Series	Antenna	
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)	
C	Material	High K material	
D	Working Frequency	2.4 ~ 2.5GHz	
E	Feeding mode	PIFA & Single Feeding	
F	Antenna type	Type = 02	
G	Mark type	Type = 01	

## 1. Electrical Specification

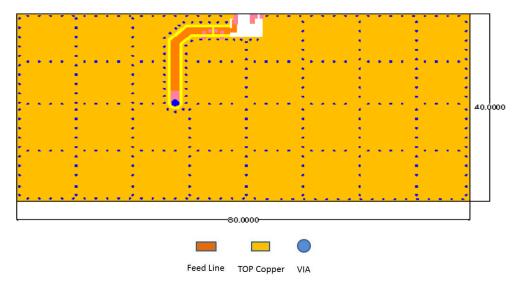
Specification				
Part Number	KBAN3216E245H0201			
Central Frequency	2450	MHz		
Bandwidth	120 (Min.)	MHz		
Return Loss	-6.5 (Max)	dB		
Peak Gain	1.71	dBi		
Impedance	50	Ohm		
Operating Temperature	-40~+110	$^{\circ}\!\mathbb{C}$		
Maximum Power	4	W		
Resistance to Soldering Heats	10 ( @ 260℃)	sec.		
Polarization	Linear			
Azimuth Beamwidth	Omni-directional			
Termination	Ni / Au (Leadless)			

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page

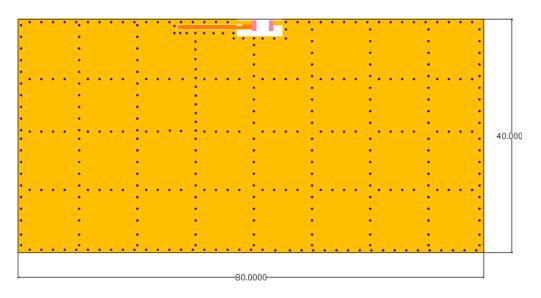


## 2. Recommended PCB Pattern

Recommended PCB Pattern 若未參照我司規格書上Layout建議做設計, Evaluation Board Dimension 進而造成後續生產上的天線特性與品質差異問題,



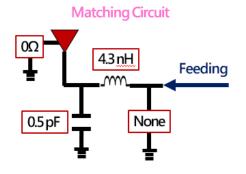
## 2<sup>nd</sup> Evaluation Board Dimension



## **Suggested Matching Circuit**

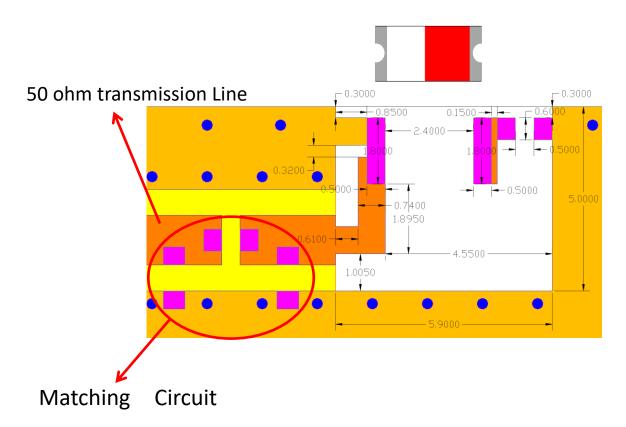
## 重要資訊:

匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF

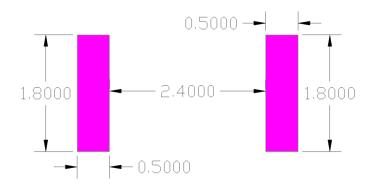




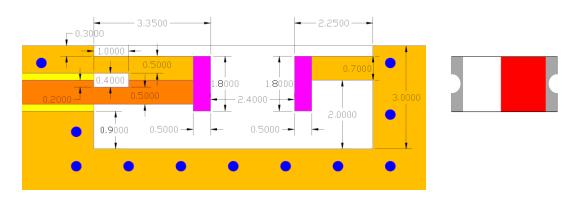
#### Layout Dimensions in Clearance area(Size=5.9\*5.0mm)



#### FootPrint (Unit:mm)

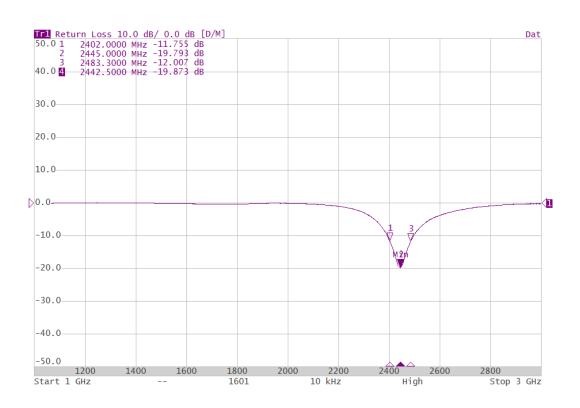


## ◆ 2<sup>nd</sup> Layout Dimensions in Clearance area(size=8.0\*3.0mm)



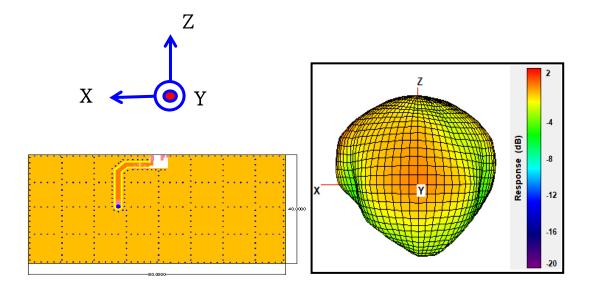


## 3. Measurement Results Return Loss



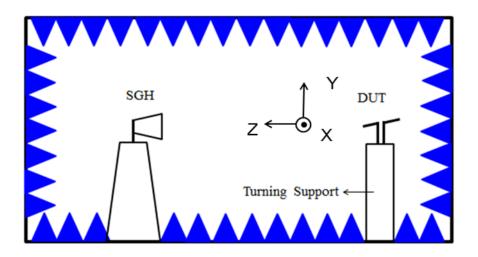


#### **Radiation Pattern**



	Efficiency	Peak Gain	Directivity
2400MHz	77.26 %	1.63 dBi	2.75 dBi
2450MHz	79.88 %	1.71 dBi	2.68 dBi
2500MHz	77.98 %	1.67 dBi	2.75 dBi

## **Chamber Coordinate System**





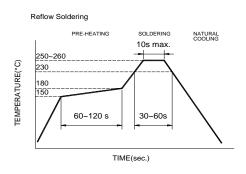
**4.Reliability and Test Condictions** 

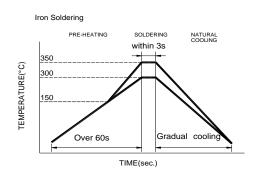
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	Wetting shall exceed 90% coverage     No visible mechanical damage	Pre-heating temperature:150 $^{\circ}$ C/60sec. Solder temperature:230 $^{\pm}$ 5 $^{\circ}$ C		
	TEMP (℃)	Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
	230°C 4±1 sec.			
	230 C			
	150°C			
	60sec			
Solder heat Resistance	No visible mechanical damage     Central Freq. change :within ± 6%	Pre-heating temperature:150 $^{\circ}$ C/60sec. Solder temperature:260 $\pm$ 5 $^{\circ}$ C		
	TEMP (℃)	Duration:10±0.5sec.		
	260°C 10±0.5 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
		Trax for feda free. To sin		
	150°C			
	60sec			
Component	No visible mechanical damage	The device should be reflow		
Adhesion (Push test)		soldered(230±5°C for 10sec.) to a tinned		
(		copper substrate A dynometer force gauge should be applied the side of the component. The device must with-ST-F 0.5 Kg without failure of the termination		
		attached to component.		
Component	No visible mechanical damage	Insert 10cm wire into the remaining open		
Adhesion (Pull test)		eye bend ,the ends of even wire lengths upward and wind together.		
(i dii toot)		Terminal shall not be remarkably		
The second of sector	4. No visible week arised demand	damaged. +110°C=>30±3min		
Thermal shock	<ol> <li>No visible mechanical damage</li> <li>Central Freq. change :within ±6%</li> </ol>	-40°C=>30±3min		
	Phase Temperature(°C) Time(min)	Test cycle:10 cycles		
	1 +110±5°C 30±3	The chip shall be stabilized at normal condition for 2~3 hours before		
	2 Room Within	measuring.		
	Temperature 3sec			
	3 -40±2°C 30±3 4 Room Within			
	4 Room Within Temperature 3sec			
Resistance to	No visible mechanical damage	Temperature: +110±5℃		
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal condition for 2~3 hours before		
		measuring.		
Resistance to	1. No visible mechanical damage	Temperature:-40±5°C		
Low Temperature	2. Central Freq. change :within ±6%	Duration: 1000±12hrs  The chip shall be stabilized at normal		
remperature	3. No disconnection or short circuit.	condition for 2~3 hours before		
		measuring.		
Humidity	No visible mechanical damage     Occurred From the agree within a COV.	Temperature: 40±2°C Humidity: 90% to 95% RH		
	Central Freq. change :within ±6%     No disconnection or short circuit.	Duration: 1000±12hrs		
	3. NO disconnection of short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before measuring.		



#### 5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

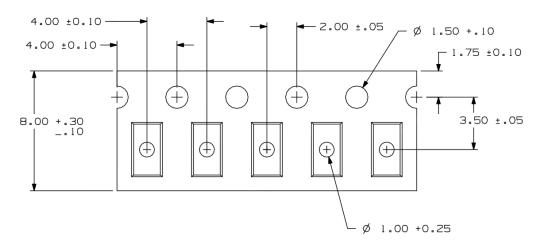
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

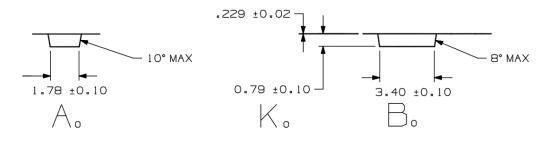
- Preheat circuit and products to 150°C
- · Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- · Limit soldering time to 3 sec.



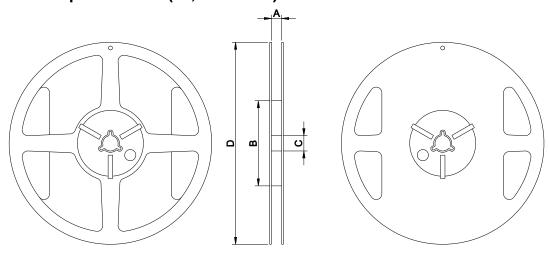
## 6.Packaging Information

## **Tape Specification:**





## Reel Specification: (7", Ф180 mm)



7" x 8 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.